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Application No.	Applicant(s)	<u>-</u>
10/083,211	SATOH, KAZUHIRO	
Examiner	Art Unit	
Benivam Menheni	2826	

SEARCHED			
Class	Subclass	Date	Examiner
341	22,23,20	3/30/2005	ВМ
345	168,172	3/30/2005	ВМ
358	1.9,400	3/30/2005	вм
358	.440	3/30/2005	ВМ
379	433.07	3/30/2005	8M
· 340	407.2	3/30/2005	BM
709	227	3/30/2005	·BM
710	67	3/30/2005	ВМ
715	535	3/30/2005	ВМ
400	486	3/30/2005	ВМ
400	89:	.8/23/06	BM
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INTERFERENCE SEARCHED				
Class	Subclass	Oate	Examiner	
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SEARCH NOTES. (INCLUDING SEARCH STRATEGY)			
•	DATE	EXMR	
searched EAST	3/24/2005	ВМ	
inventor name search	3/30/2005	8M	
IEEE searched	3/30/2005	BM	
searched EAST	9/30/2005	81	
sourched EAST.	2/27/06	ВМ	
Searched EAST	8/2/06	BM	
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